

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10644425	SIBILLE ET AL.
	Examiner	Art Unit
	Moutaouakil, Mounir	2616

SEARCHED			
Class	Subclass	Date	Examiner
370	395.52	4/27/2007	MM
370	466	4/27/2007	MM
370	395.6	5/4/2007	MM
370	469	4/27/2007	MM
370	467	4/27/2007	MM
370	410	4/27/2007	MM
370	522	4/27/2007	MM
370	524	4/27/2007	MM
370	401	4/27/2007	MM

SEARCH NOTES			
Search Notes	Date	Examiner	
Consulted with Hassan Kizou (SPE)	4/26/2007	MM	
EAST	4/26/2007	MM	
Inventorship search	4/26/2007	MM	
IEEE Xplore	4/26/2007	MM	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner